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Standards

Irish Standard  
I.S. EN 61326-2-1:2013

Electrical equipment for measurement, control and laboratory use - EMC requirements -- Part 2-1: Particular requirements - Test configurations, operational conditions and performance criteria for sensitive test and measurement equipment for EMC unprotected applications (IEC 61326-2-1:2012 (EQV))

## I.S. EN 61326-2-1:2013

*Incorporating amendments/corrigenda issued since publication:*

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I.S. xxx: Irish Standard – national specification based on the consensus of an expert panel and subject to public consultation.

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<i>This document replaces:</i> EN 61326-2-1:2006	<i>This document is based on:</i> EN 61326-2-1:2013 EN 61326-2-1:2006	<i>Published:</i> 11 January, 2013 5 May, 2006
This document was published under the authority of the NSAI and comes into effect on:  14 February, 2013		ICS number: 17.220 25.040.40 33.100
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English version

**Electrical equipment for measurement, control and laboratory use -  
EMC requirements -  
Part 2-1: Particular requirements -  
Test configurations, operational conditions and performance criteria for  
sensitive test and measurement equipment for EMC unprotected  
applications  
(IEC 61326-2-1:2012)**

Matériel électrique de mesure, de  
commande et de laboratoire -  
Exigences relatives à la CEM -  
Partie 2-1: Exigences particulières -  
Configurations d'essai, conditions  
fonctionnelles et critères de performance  
pour essai de sensibilité et équipement de  
mesures pour les applications non  
protégées de la CEM  
(CEI 61326-2-1:2012)

Elektrische Mess-, Steuer-, Regel- und  
Laborgeräte – EMV-Anforderungen – Teil  
2-1: Besondere Anforderungen –  
Prüfanordnung, Betriebsbedingungen und  
Leistungsmerkmale für empfindliche Prüf-  
und Messgeräte für Anwendungen ohne  
EMV-Schutzmaßnahmen  
(IEC 61326-2-1:2012)

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European Committee for Electrotechnical Standardization  
Comité Européen de Normalisation Electrotechnique  
Europäisches Komitee für Elektrotechnische Normung

**Management Centre: Avenue Marnix 17, B - 1000 Brussels**

## Foreword

The text of document 65A/641/FDIS, future edition 2 of IEC 61326-2-1, prepared by SC 65A, "System aspects", of IEC TC 65, "Industrial-process measurement, control and automation" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 61326-2-1:2013.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2013-08-06
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2015-11-06

This document supersedes EN 61326-2-1:2006.

EN 61326-2-1:2013 includes the following significant technical changes with respect to EN 61326-2-1:2006:

– Update with respect to EN 61326-1:2013.

EN 61326-2-1:2013 is to be used in conjunction with EN 61326-1:2013 and follows the same numbering of clauses, subclauses, tables and figures.

When a particular subclause of EN 61326-1 is not mentioned in this part, that subclause applies as far as is reasonable. When this standard states "addition", "modification" or "replacement", the relevant text in EN 61326-1 is to be adapted accordingly.

NOTE The following numbering system is used:

- subclauses, tables and figures that are numbered starting from 101 are additional to those in EN 61326-1;
- unless notes are in a new subclause or involve notes in EN 61326-1, they are numbered starting from 101 including those in a replaced clause or subclause;
- additional annexes are lettered AA, BB, etc.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CENELEC [and/or CEN] shall not be held responsible for identifying any or all such patent rights.

This document has been prepared under a mandate given to CENELEC by the European Commission and the European Free Trade Association, and supports essential requirements of EU Directive(s).

For the relationship with EU Directive(s) see informative Annex ZZ, which is an integral part of this document.

## Endorsement notice

The text of the International Standard IEC 61326-2-1:2012 was approved by CENELEC as a European Standard without any modification.

## Annex ZA (normative)

### Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

*Annex ZA of EN 61326-1:2013 applies, except as follows:*

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
<i>Addition:</i>				
IEC 61326-1	2012	Electrical equipment for measurement, control and laboratory use - EMC requirements - Part 1: General requirements	EN 61326-1	2013

**Annex ZZ**  
(informative)

**Coverage of Essential Requirements of EU Directives**

This European Standard has been prepared under a mandate given to CENELEC by the European Commission and the European Free Trade Association and within its scope the standard covers protection requirements of Annex I, Article 1 of the EC Directive 2004/108/EC.

Compliance with this standard provides one means of conformity with the specified essential requirements of the Directive[s] concerned.

NOTE Other requirements and other EU Directives may be applicable to the products falling within the scope of this standard.

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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**ELECTRICAL EQUIPMENT FOR MEASUREMENT,  
CONTROL AND LABORATORY USE –  
EMC REQUIREMENTS –**

**Part 2-1: Particular requirements –  
Test configurations, operational conditions and performance  
criteria for sensitive test and measurement equipment  
for EMC unprotected applications**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 61326-2-1 has been prepared by subcommittee 65A: System aspects, of IEC technical committee 65: Industrial-process measurement, control and automation.

This second edition cancels and replaces the first edition published in 2005. This edition constitutes a technical revision.



The main technical changes with regard to the previous edition are as follows:

- Update with respect to IEC 61326-1:2012.

The text of this standard is based on the following documents:

FDIS	Report on voting
65A/641/FDIS	65A/652/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

This part of IEC 61326 series is to be used in conjunction with IEC 61326-1:2012 and follows the same numbering of clauses, subclauses, tables and figures.

When a particular subclause of IEC 61326-1 is not mentioned in this part, that subclause applies as far as is reasonable. When this standard states “addition”, “modification” or “replacement”, the relevant text in IEC 61326-1 is to be adapted accordingly.

NOTE The following numbering system is used:

- subclauses, tables and figures that are numbered starting from 101 are additional to those in IEC 61326-1;
- unless notes are in a new subclause or involve notes in IEC 61326-1, they are numbered starting from 101 including those in a replaced clause or subclause;
- additional annexes are lettered AA, BB, etc.

A list of all parts of IEC 61326 series, under the general title *Electrical equipment for measurement, control and laboratory use – EMC requirements* can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

## **ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS –**

### **Part 2-1: Particular requirements – Test configurations, operational conditions and performance criteria for sensitive test and measurement equipment for EMC unprotected applications**

#### **1 Scope**

In addition to the scope of IEC 61326-1, this part of IEC 61326 specifies more detailed test configurations, operational conditions and performance criteria for equipment with test and measurement circuits (both internal and/or external to the equipment) that are not EMC protected for operational and/or functional reasons, as specified by the manufacturer.

The manufacturer specifies the environment for which the product is intended to be used and selects the appropriate test level specifications of IEC 61326-1.

NOTE Examples of equipment include, but are not limited to, oscilloscopes, logic analysers, spectrum analysers, network analysers, analogue instruments, digital multimeters (DMM) and board test systems.

#### **2 Normative references**

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

Clause 2 of IEC 61326-1 applies, except as follows:

*Addition:*

IEC 61326-1: 2012, *Electrical equipment for measurement, control and laboratory use – EMC requirements – Part 1: General requirements*

#### **3 Terms and definitions**

For the purposes of this document, the terms and definitions given in IEC 61326-1 and IEC 60050-161 apply.

#### **4 General**

Clause 4 of IEC 61326-1 applies.

#### **5 EMC test plan**

##### **5.1 General**

Subclause 5.1 of IEC 61326-1 applies.

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